**TOSHIBA** 2SD798

### TOSHIBA TRANSISTOR SILICON NPN TRIPLE DIFFUSED TYPE

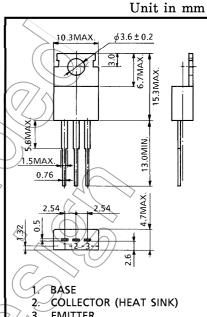
# 2SD798

### **IGNITER APPLICATIONS**

### HIGH VOLTAGE SWITCHING APPLICATIONS

High DC Current Gain :  $h_{FE} = 1500$  (Min.) ( $V_{CE} = 2V$ ,  $I_{C} = 2A$ )

## INDUSTRIAL APPLICATIONS



EMITTER

JEDEC	TO-220AB	
EIAJ	SC-46	
TOSHIBA	2-10A1A	

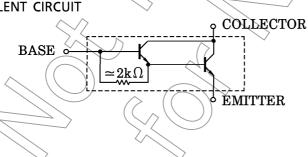
Weight: 1.9g

Mounting Kit No. AC75

### MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	TINU
•	2		
Collector-Base Voltage	VcBQ	600 <<	V
Collector-Emitter Voltage	VCEO	300	V
Emitter-Base Voltage	VEBO	5	A
Collector Current	\_I^IC/	6	Α
Base Current	$\langle I^{\mathbf{B}} \rangle$	1	Α
Collector Power Dissipation	Δ Dα	30	w
(Tc=25°C)	ightharpoonupPC	30	l vv
Junction Temperature	T <sub>j</sub>	(//150)	°C
Storage Temperature Range	T <sub>stg</sub>	<b>-55~150</b>	°C

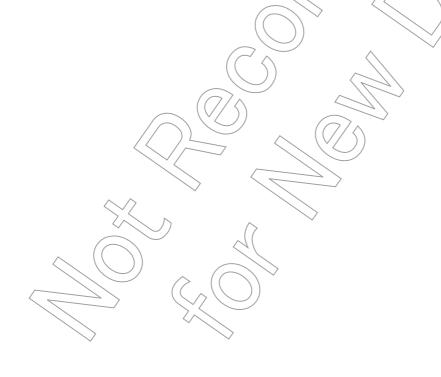
### **EQUIVALENT CIRCUIT**



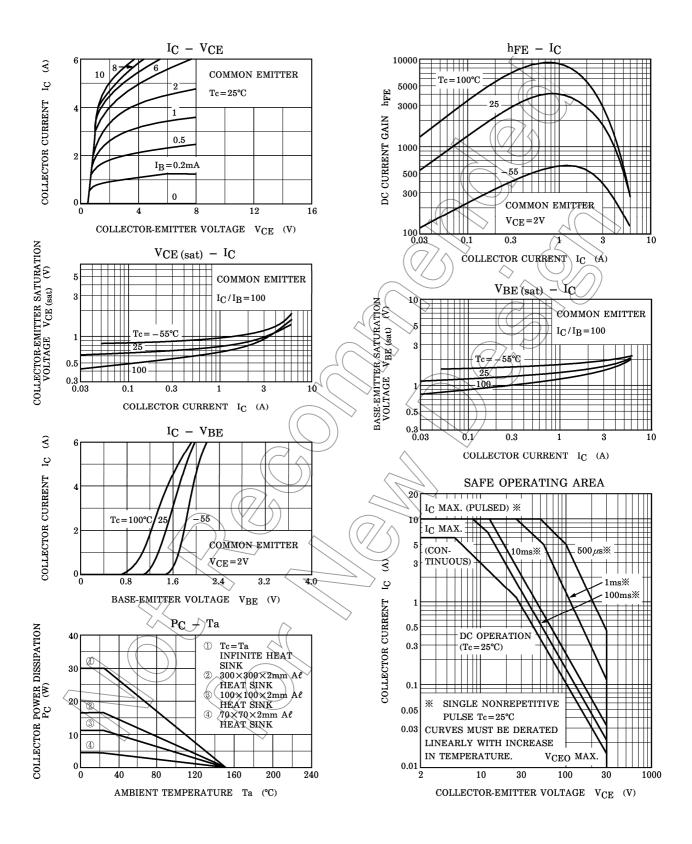
2001-05-24

### ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARAC	CTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current		$I_{CBO}$	$V_{CB} = 600V, I_{E} = 0$	$\nearrow$	_	0.5	mA
Emitter Cut-off Current		$I_{EBO}$	$V_{EB}=5V, I_{C}=0$		5-	0.5	mA
Collector-Emit Voltage	ter Sustaining	VCEO (SUS)	I <sub>C</sub> =0.5A, L=40mH	300	7_	_	V
DC Current Gain		h <sub>FE (1)</sub>	$V_{CE}=2V, I_{C}=2A$	1500	_	_	
		h <sub>FE</sub> (2)	$V_{CE}=2V, I_{C}=4A$	200	_	_	
Collector-Emit Voltage	ter Saturation	V <sub>CE</sub> (sat)	$I_{C}=4A, I_{B}=0.04A$	<i>_</i>	_(	2.0	V
Base-Emitter : Voltage	Saturation	V <sub>BE</sub> (sat)	I <sub>C</sub> =4A, I <sub>B</sub> =0.04A			2.5	V
Collector Output Capacitance		$C_{ob}$	$V_{CB} = 50V$ , $I_{E} \neq 0$ , $f \approx 1MHz$	-(	35	_	pF
Switching Time	Turn-on Time	t <sub>on</sub>	OUTPUT OUTPUT 20 µs PUT B1		1	_	
	Storage Time	$t_{ ext{stg}}$		(A)	8	_	$\mu$ s
	Fall Time	$t_f$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	) _	5	_	



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